


<b>Search Notes</b>  	<b>Application/Control No.</b>  10627962	<b>Applicant(s)/Patent Under Reexamination</b>  PIIRAINEN ET AL.
	<b>Examiner</b>  Lee, Siu M	<b>Art Unit</b>  2611

### SEARCHED

Class	Subclass	Date	Examiner
375	146, 148, 295, 296, 297, 300, 343	10/13/2006	Siu Lee

### SEARCH NOTES

Search Notes	Date	Examiner
Discuss the application with Chieh Fan	10/13/2006	Siu Lee
EAST	10/11/2006	Siu Lee
Google	10/10/2006	Siu Lee
EAST	7/27/2007	Siu M. Lee
Discuss the amendment with Chieh Fan	7/27/2007	Siu M. Lee
EAST	1/14/2008	Siu M. Lee
Discuss the amendment with Chieh Fan	1/14/2008	Siu M. Lee
EAST	8/26/2008	Siu M. Lee
Discuss the amendment with Chieh Fan	8/27/2008	Siu M. Lee
EAST	2/23/2009	Siu M. Lee
Discuss the application with Chieh Fan	2/23/2009	Siu M. Lee
EAST	8/25/2009	Siu M. Lee
Discuss the amendment with Chieh Fan	8/25/2009	Siu M. Lee

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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